

## N-Channel 80 V (D-S) MOSFET

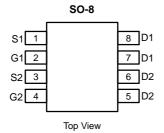
PRODUCT SUMMARY					
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)		
80	0.062 at $V_{GS}$ = 10 V	3.5	7.3 nC		
00			7.5110		

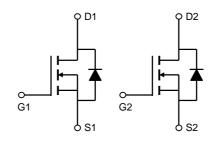
#### FEATURES

- Halogen-free According to IEC 61249-2-21
  Definition
- TrenchFET<sup>®</sup> Power MOSFET
- 100 % R<sub>q</sub> and UIS Tested
- Compliant to RoHS Directive 2002/95/EC

#### **APPLICATIONS**

DC/DC Conversion
 Notebook System Power





Absolute Maximum Ratings T <sub>A</sub> =25 <sup>°</sup> C unless otherwise noted						
Parameter		Symbol	Maximum	Units		
Drain-Source Voltage		V <sub>DS</sub>	80	V		
Gate-Source Voltage		V <sub>GS</sub>	±30	V		
Continuous Drain Current	T <sub>A</sub> =25℃		3.5			
	T <sub>A</sub> =70℃	I <sub>D</sub>	2.9	А		
Pulsed Drain Current <sup>C</sup>		I <sub>DM</sub>	18			
Avalanche Current <sup>C</sup>		I <sub>AR</sub>	16	А		
Repetitive avalanche energy L=0.1mH <sup>C</sup>		E <sub>AR</sub>	12.8	mJ		
Power Dissipation <sup>B</sup>	T <sub>A</sub> =25℃	- P <sub>D</sub>	2	W		
	T <sub>A</sub> =70℃	' D	1.3	٧V		
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	Ĵ		

Thermal Characteristics					
Parameter	Symbol	Тур	Max	Units	
Maximum Junction-to-Ambient <sup>A</sup>	t ≤ 10s	Р	48	62.5	℃/W
Maximum Junction-to-Ambient AD	Steady-State	R <sub>0JA</sub>	74	90	°C/W
Maximum Junction-to-Lead	Steady-State	$R_{ ext{ hetaJL}}$	32	40	℃/W



Available



Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC PARAMETERS							
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$I_D=250\mu A$ , $V_{GS}=0V$		80			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS}$ =80V, $V_{GS}$ =0V				1	μA
USS			T_=55℃			5	μΛ
I <sub>GSS</sub>	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ = ±30V				100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS}=V_{GS}$ I <sub>D</sub> =250µA		3.5	4.2	5	V
I <sub>D(ON)</sub>	On state drain current	$V_{GS}$ =10V, $V_{DS}$ =5V		18			Α
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =3.5A			62		mΩ
US(ON)			T <sub>J</sub> =125℃		113.0		11152
<b>g</b> <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =3.5A			15		S
V <sub>SD</sub>	Diode Forward Voltage	I <sub>S</sub> =1A,V <sub>GS</sub> =0V			0.77	1	V
I <sub>S</sub>	Maximum Body-Diode Continuous Curre	1aximum Body-Diode Continuous Current				2.5	Α
I <sub>SM</sub>	Pulsed Body-diode Current <sup>C</sup>					18	Α
DYNAMIC	PARAMETERS						
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =40V, f=1MHz V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz		510	640	770	pF
C <sub>oss</sub>	Output Capacitance			28	40	52	pF
C <sub>rss</sub>	Reverse Transfer Capacitance			12	20	30	pF
R <sub>g</sub>	Gate resistance			0.9	1.8	2.7	Ω
SWITCHI	NG PARAMETERS						
Q <sub>g</sub> (10V)	Total Gate Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =40V, I <sub>D</sub> =3.5A		8	11	13	nC
Q <sub>g</sub> (4.5V)	Total Gate Charge			4	5.5	7	
Q <sub>gs</sub>	Gate Source Charge			4	5	6	nC
Q <sub>gd</sub>	Gate Drain Charge			0.7	1.2	1.7	nC
t <sub>D(on)</sub>	Turn-On DelayTime				7.2		ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =40V, $R_{L}$ =8 $\Omega$ , $R_{GEN}$ =3 $\Omega$			2.2		ns
t <sub>D(off)</sub>	Turn-Off DelayTime				17		ns
t <sub>f</sub>	Turn-Off Fall Time				2		ns
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =3.5A, dI/dt=300A/µ	ιs	14	20	26	ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>F</sub> =3.5A, dI/dt=300A/µ	ιs	35	50	65	nC

A. The value of  $R_{BJA}$  is measured with the device mounted on  $1in^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25$ °C. The value in any given application depends on the user's specific board design.

B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}=150$ °C, using  $\leq 10$ s junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}=150$ °C. Ratings are based on low frequency and duty cycles to keep initial  $T_{J}=25$ °C.

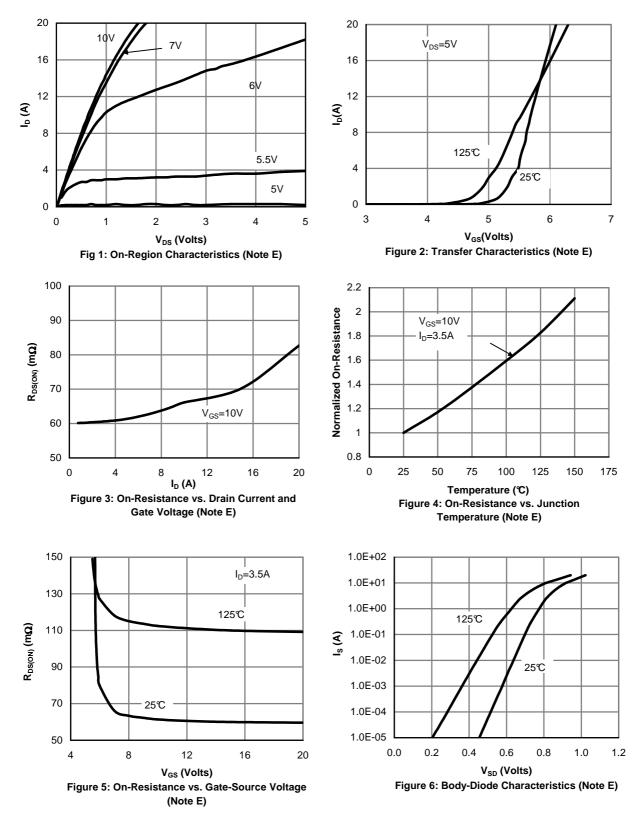
D. The  $R_{\theta JA}$  is the sum of the thermal impedence from junction to lead  $R_{\theta JL}$  and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 $\mu$ s pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedence which is measured with the device mounted on 1in<sup>2</sup> FR-4 board with



#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





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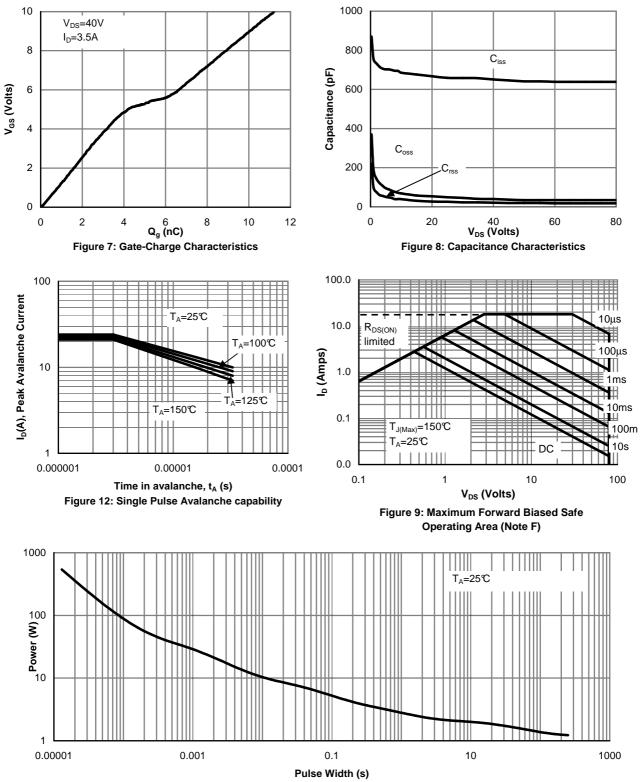
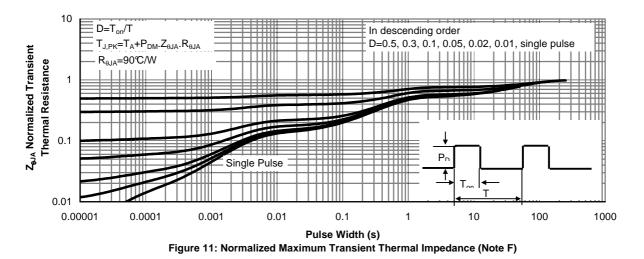


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note F)



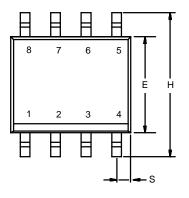
#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





### SOIC (NARROW): 8-LEAD

JEDEC Part Number: MS-012

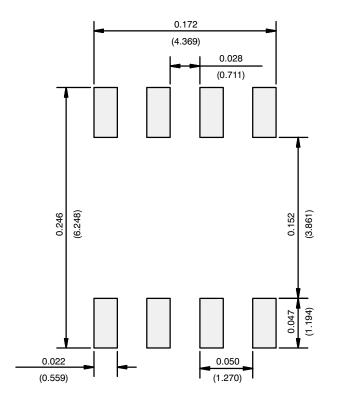




	MILLIMETERS		INCHES			
DIM	Min	Max	Min	Max		
A	1.35	1.75	0.053	0.069		
A <sub>1</sub>	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
E	3.80	4.00	0.150	0.157		
е	1.27 BSC		0.050	BSC		
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
ECN: C-06527-Rev. I, 11-Sep-06 DWG: 5498						



#### **RECOMMENDED MINIMUM PADS FOR SO-8**



Recommended Minimum Pads Dimensions in Inches/(mm)

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